# Notice of References Cited Application/Control No. 10/759,453 Examiner EMEM EKONG Applicant(s)/Patent Under Reexamination BAJKO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,835,484	11-1998	Yamato et al.	370/230
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